

Application/Control No.	Applicant(s)/Patent under Reexamination
10/668,185	SHIGIHARA ET AL.
Examiner	Art Unit
Erin D. Chiem	2883

SEARCHED				
Class	Subclass	Date	Examiner	
385	131	5/11/2005	EDC	
372	45	5/11/2005	EDC	
257	49,91	5/11/2005	EDC	
428	213	5/11/2005	EDC	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
Fibs	Remove	Q5/11/05	EOC.		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
text search	5/11/2005	EDC		
inventorship search	5/11/2005	edc		
EAST Search (See printont for Strategi)	s/ulos	ERC		
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